


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/729,491	LEEK, WILLIAM F.	
	Examiner	Art Unit	
	PHI D. A	3633	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
52		295			52	293.3	296	223.13	298	223.14
INTERNATIONAL CLASSIFICATION					411	231	917			
E	0	2	D	35/00						
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					Total Claims Allowed: 19 O.G. Print Claim(s) O.G. Print Fig. 1 4B					
(Assistant Examiner) (Date) (Legal Instruments Examiner) (Date)										
					/Phi D. A/ 10/25/08 PHI DIEU TRAN A (Primary Examiner) (Date)					

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input checked="" type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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